Search Notes			

09/828,163 Examiner

Hai C. Pham

Applicant(s)/Patent under Reexamination

MIYAGAWA, ICHIROU

Art Unit

2861

	SEARCHED				
Class	Subclass	Date	Examiner		
347	233, 236- 237, 246- 247, 253	3/28/2005	HP		
250	503.1	3/28/2005	НР		
372	29.02	3/28/2005	HP		

INTERFERENCE SEARCHED				
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(INCLUDING SEAR	CHSTRATEGY)
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EAST TEXT SEARCH	3/28/2005	НР
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